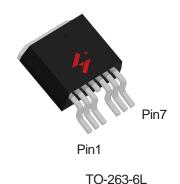


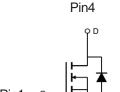
N-Channel Enhancement Mode MOSFET

Feature Description

- 80V/255A $R_{DS(ON)} = 2.6m\Omega(typ.)@Vgs = 10V$
- 100% Avalanche Tested
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

Pin Description





Pin2,3,5,6,7

N-Channel MOSFET

Applications

- Switch application
- Brushless Motor Drive

Ordering and Marking Information



Note: HUAYI lead -free products contain molding compounds/die attach materials and 100% matte tin plate Termi-Nation finish; which are fully compliant with RoHS. HUAYI lead -free products meet or exceed the lead-Free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
Common Ra	tings (Tc=25°C Unless Otherwise Noted)			•
VDSS	Drain-Source Voltage		80	V
Vgss	Gate-Source Voltage		±25	V
TJ	Maximum Junction Temperature		175	°C
Тѕтс	Storage Temperature Range	-55 to 175	°C	
ls	Source Current-Continuous(Body Diode) Tc=25°C		255	А
Mounted on	Large Heat Sink		-	
Ірм	Pulsed Drain Current *	Tc=25°C	918	А
1	Continuous Dania Comment	Tc=25°C	255	А
lD	Continuous Drain Current	Tc=100°C	180	А
-	M : 5 5: : ::	Tc=25°C	375	W
PD	P _D Maximum Power Dissipation Tc=100		187	W
R _e uc	Thermal Resistance, Junction-to-Case		0.40	°C/W
R _{eJA}	Thermal Resistance, Junction-to-Ambient **		40	°C/W
Eas	SinglePulsed-Avalanche Energy *** L=0.5mH		1512	mJ

Note: * Repetitive rating; pulse width limited by max.junction temperature.

** Surface mounted on FR-4 board.

*** Limited by TJmax , starting TJ=25°C, L =0.5mH, Rg= 25Ω , Vgs =10V.

Electrical Characteristics(Tc =25°C Unless Otherwise Noted)

Comple ed	Donomoton.	Parameter Test Conditions		HY4008		1114	
Symbol	Parameter			Min	Тур.	Max	Unit
Static Characteristics							
BVDSS	Drain-Source Breakdown Voltage	$V_{GS}=0V,I_{DS}=250\mu A$		80	-	-	V
lana	Drain-to-Source Leakage Current	VDS=80V,VGS=0V		-	-	1	μΑ
IDSS			TJ=55°C	-	-	5	μΑ
VGS(th)	Gate Threshold Voltage	Vos=Vgs, I _{DS} =250µA		2	3	4	V
Igss	Gate-Source Leakage Current	$V_{GS}=\pm 25V, V_{DS}=0V$		-	-	±100	nA
RDS(ON)*	Drain-Source On-State Resistance	V _{GS} =10V,I _{DS} =110A		-	2.6	3.2	mΩ
Diode Characteristics							
Vsp*	Diode Forward Voltage	IsD=110A,Vgs=0V		-	0.8	1.2	V
trr	Reverse Recovery Time	Isp=110A,dIsp/dt=100A/µs		-	30	-	ns
Qrr	Reverse Recovery Charge			-	52	-	nC

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Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

Cumbal	Dougneste:	Took Conditions	HY4008			Unit
Symbol	Parameter Test Conditions	Min	Тур.	Max		
Dynamic (Dynamic Characteristics					
Rg	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1 MHz	-	1.9	-	Ω
Ciss	Input Capacitance	Vgs=0V,	-	7457	-	
Coss	Output Capacitance	V _{DS} =25V,	-	1217	-	pF
Crss	Reverse Transfer Capacitance	Frequency=1.0MHz	-	822	-	
td(ON)	Turn-on Delay Time		-	28	-	
Tr	Turn-on Rise Time	$V_{DD}=50V,R_{G}=6\Omega,$	-	18	-	no
td(OFF)	Turn-off Delay Time	los=110A,Vgs=10V	-	42	-	ns
Tf	Turn-off Fall Time		-	54	-	
Gate Charge Characteristics						
Qg	Total Gate Charge	\/ _64\/ \/ _10\/	-	209	-	
Qgs	Gate-Source Charge	$V_{DS} = 64V, V_{GS} = 10V,$ $I_{D} = 110A$	-	33	-	nC
Q_{gd}	Gate-Drain Charge		-	83	-	

Note: *Pulse test, pulse width ≤ 300us, duty cycle ≤ 2%



Typical Operating Characteristics

Figure 1: Power Dissipation

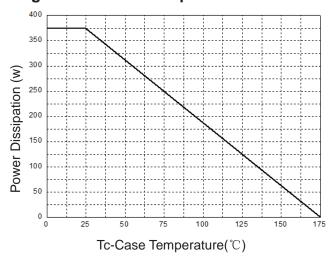


Figure 2: Drain Current

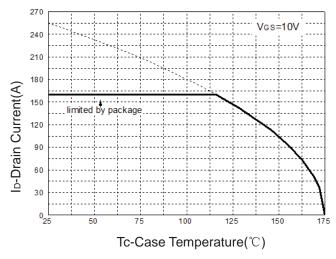


Figure 3: Safe Operation Area

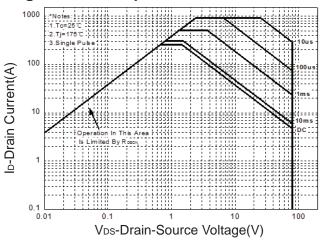


Figure 5: Output Characteristics

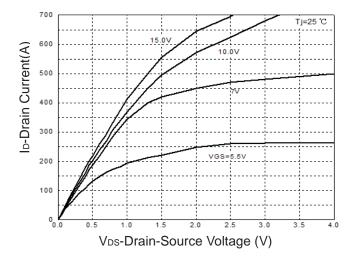


Figure 4: Thermal Transient Impedance

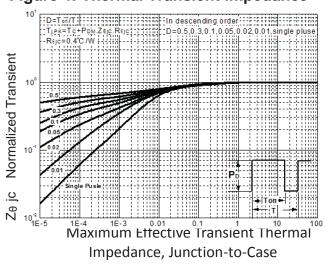
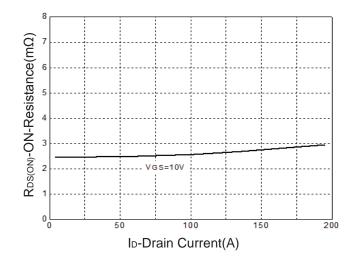


Figure 6: Drain-Source On Resistance





Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature

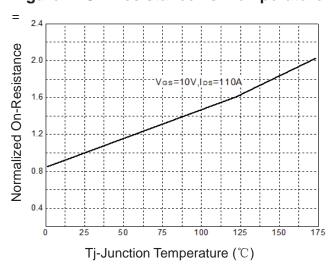


Figure 9: Capacitance Characteristics

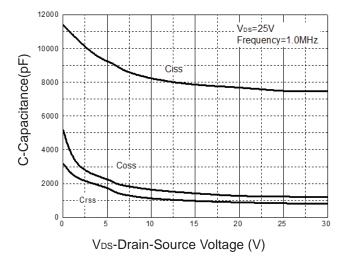


Figure 8: Source-Drain Diode Forward

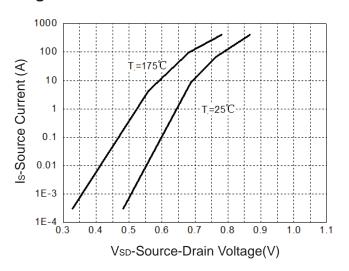
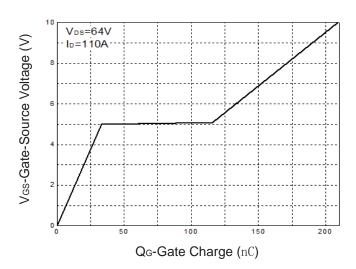
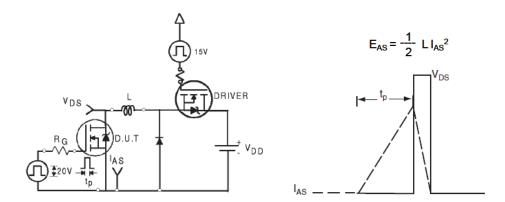


Figure 10: Gate Charge Characteristics

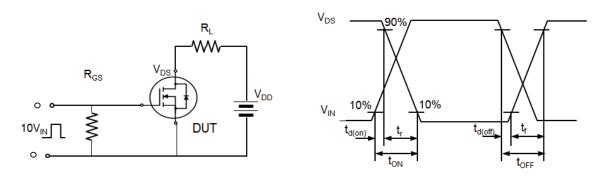




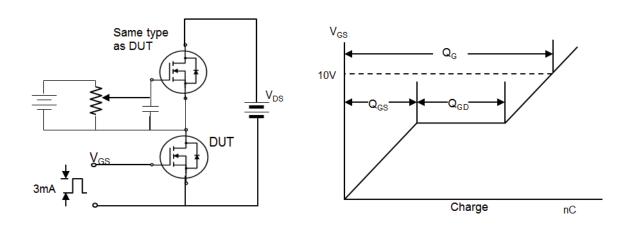
Avalanche Test Circuit and Waveforms



Switching Time Test Circuit and Waveforms



Gate Charge Test Circuit and Waveforms



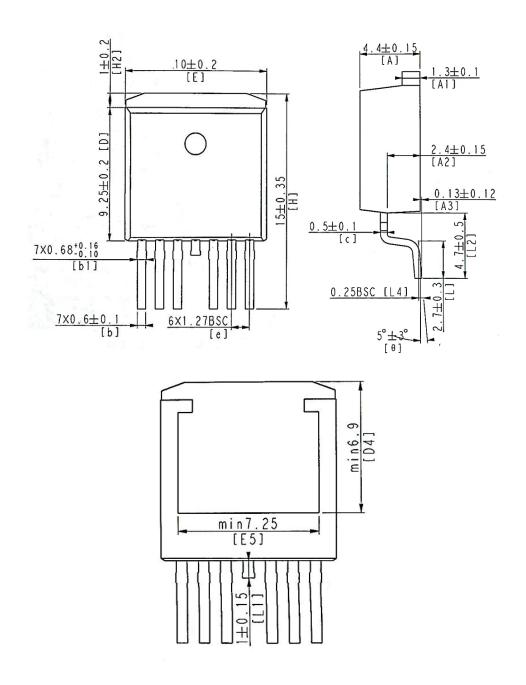


Device Per Unit

Package Type	Unit	Quantity
TO-263-6L	Tube	50

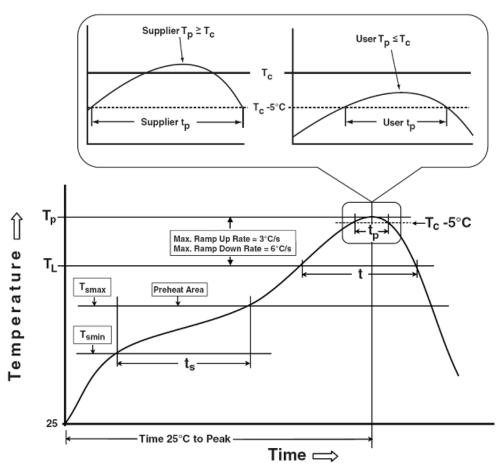
Package Information

TO-263-6L





Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly		
Preheat & Soak Temperature min (T _{smin})	100 °C	150 °C		
Temperature max (T _{smax}) Time (Tsmin to Tsmax) (t _s)	150 °C 60-120 seconds	200 °C 60-120 seconds		
Average ramp-up rate (T _{smax} to T _P)	3 °C/second max.	3°C/second max.		
Liquidous temperature (T _L)	183 °C	217 °C		
Time at liquidous (t _L)	60-150 seconds	60-150 seconds		
Peak package body Temperature (T _P)*	See Classification Temp in table 1	SeeClassification Tempin table 2		
Time (t _P)** within 5°C of the specified classification temperature (T _☉)	20** seconds	30** seconds		
Average ramp-down rate (Tpto Tsmax)	6 °C/second max.	6 °C/second max.		
Time 25°C to peak temperature	6 minutes max.	8 minutes max.		
*Toloronge for neal, profile Temperature (T.) is defined as a simpler minimum and a user maximum				

^{*}Tolerance for peak profile Temperature (T_P) is defined as a supplier minimum and a user maximum.

^{**} Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

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Table 1.SnPb Eutectic Process _ Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³
Thickness	<350	≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm ³	Volume mm ³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	1000 Hrs, Bias @ 125°C
PCT	JESD-22, A102	168 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -65°C~150°C

Customer Service

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